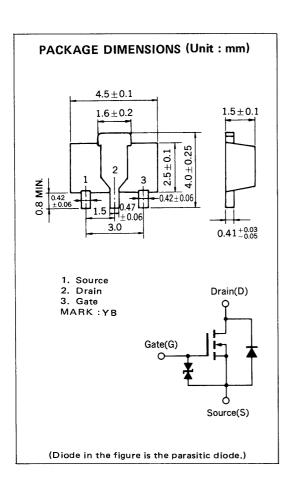


# MOS FIELD EFFECT TRANSISTOR 2SK680A

# N-CHANNEL MOS FET FOR HIGH SPEED SWITCHING



The 2SK680A, N-channel vertical type MOS FET, is a switching device which can be driven directly by the output of ICs having a 5 V power source.

The MOS FET has excellent switching characteristics and is suitable for use as a high-speed switching device in digital circuits.

### **FEATURES**

- Directly driven by ICs having a 5 V power source.
- Not necessary to consider driving current because of its high input impedance.
- Possible to reduce the number of parts by omitting the bias resistor.
- Has low on-state resistance

 $R_{DS(on)}$  = 1.0  $\Omega$  MAX. @V<sub>GS</sub> = 4.0 V,  $I_D$  = 0.5 A  $R_{DS(on)}$  = 0.7  $\Omega$  MAX. @V<sub>GS</sub> = 10 V,  $I_D$  = 0.5 A

## **QUALITY GRADE**

Standard

Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

## ABSOLUTE MAXIMUM RATINGS ( $T_a = 25$ °C)

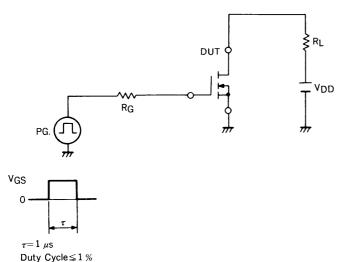
PARAMETER	SYMBOL	RATINGS	UNIT	TEST CONDITIONS
Drain to Source Voltage	V <sub>DSS</sub>	30	V	V <sub>GS</sub> = 0
Gate to Source Voltage	V <sub>GSS</sub>	±20	٧	V <sub>DS</sub> = 0
Drain Current	I <sub>D(DC)</sub>	±1.0	Α	
Drain Current	I <sub>D</sub> (pulse)	±2.0	Α	PW ≤ 10 ms, Duty Cycle ≤ 50 %
Total Power Dissipation	PT	2.0	w	when using ceramic board of 16 cm <sup>2</sup> x 0.7 mm
Channel Temperature	T <sub>ch</sub>	150	°C	
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C	

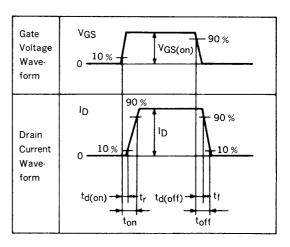


## ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = 25 °C)

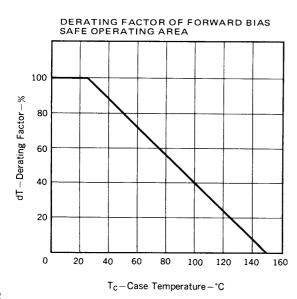
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS
Drain Cut-off Current	IDSS			10	μΑ	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0
Gate Leakage Current	IGSS			±10	μΑ	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0
Gate Cut-off Voltage	VGS(off)	1.0	1.6	2.5	V	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA
Forward Transfer Admittance	ly <sub>fs</sub> l	0.4			S	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.5 A
Drain to Source On-State Resistance	RDS(on)1		0.6	1.0	Ω	V <sub>GS</sub> = 4.0 V, I <sub>D</sub> = 0.5 A
Drain to Source On-State Resistance	R <sub>DS</sub> (on)2		0.4	0.7	Ω	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5 A
Input Capacitance	C <sub>iss</sub>		130		pF	V <sub>DS</sub> = 5.0 V, V <sub>GS</sub> = 0, f = 1 MHz
Output Capacitance	Coss		70		pF	
Feedback Capacitance	C <sub>rss</sub>		30		pF	
Turn-On Delay Time	<sup>t</sup> d(on)		12		ns	$V_{GS(on)} = 10 \text{ V, R}_{G} = 10 \Omega$ $V_{DD} = 25 \text{ V, I}_{D} = 0.5 \text{ A}$ $R_{L} = 50 \Omega$
Rise Time	t <sub>r</sub>		44		ns	
Turn-Off Delay Time	td(off)		310		ns	
Fall Time	tf		160		ns	

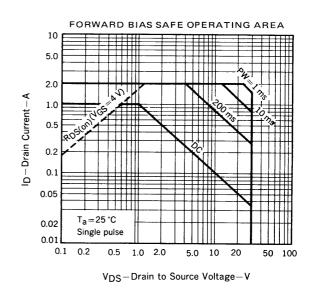
## SWITCHING TIME MEASUREMENT CIRCUIT AND CONDITIONS

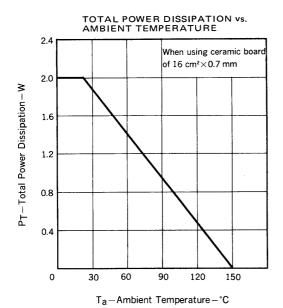


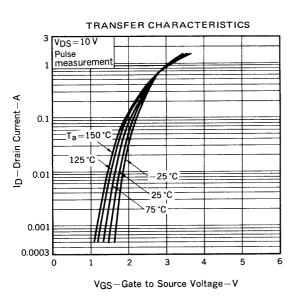


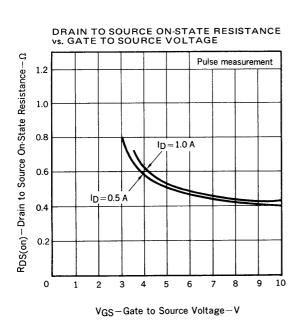
## TYPICAL CHARACTERISTICS (T<sub>a</sub> = 25 $^{\circ}$ C)

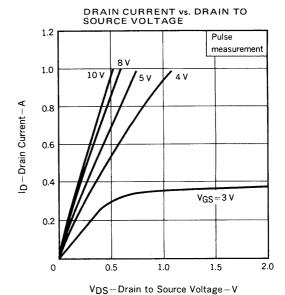


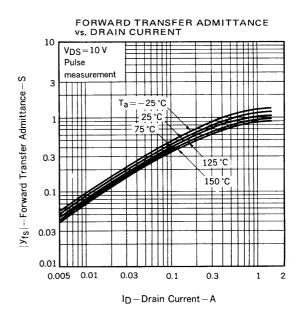


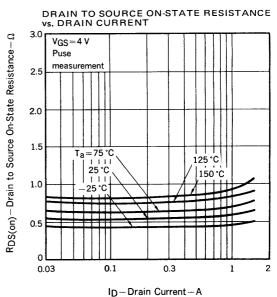


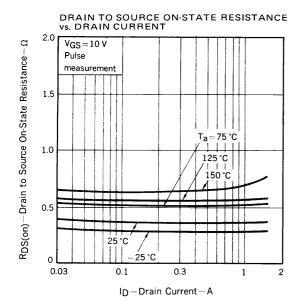


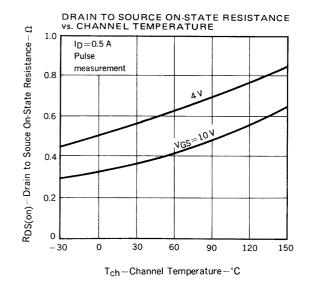


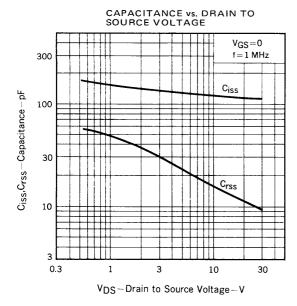


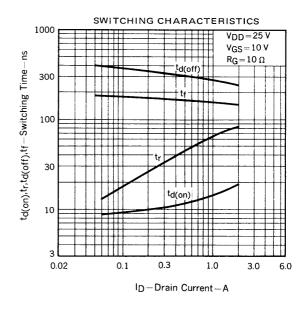


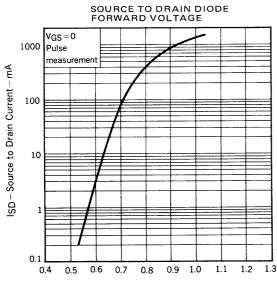












VSD-Source to Drain Voltage-V

## RECOMMENDED SOLDERING CONDITIONS

Mounting of this product by soldering should be done under the following conditions.

Please consult our representatives about soldering methods and conditions other than these.

### **SURFACE MOUNT TYPE**

For details of the recommended soldering conditions, see the information document.

"Device Mounting Manual for Surface Mounting (IEI-1207)."

Soldering Method	Soldering Conditions	Symbol for Recommended Conditions		
Infrared Reflow	Package peak temp.: 230 °C Soldering time: within 30 sec (above 210 °C) Soldering times: 1, Days limitation: none*	IR30-00		
Vapor Phase Soldering	Package peak temp.: 215 °C Soldering time: within 40 sec (above 200 °C) Soldering times: 1, Days limitation: none*	VP15-00		
Wave Soldering	Soldering bath temp.: below 260 °C Soldering time: within 10 sec Soldering times: 1, Days limitation: none*	WS60-00		

<sup>\*:</sup> Stored days under storage conditions at 25 °C and below 65 % R.H. after the dry-pack has been opened.

Note 1 Combination of soldering methods should be avoided.

### **REFERENCE**

Document Name	Document No.	
NEC semiconductor device reliability/quality control system.	TEI-1202	
Quality grade on NEC semiconductor devices.	IEI-1209	
Semiconductor device mounting technology manual.	IEI-1207	
Semiconductor device package manual.	IEI-1213	
Guide to quality assurance for semiconductor devices.	MEI-1202	
Semiconductor selection guide.	MF-1134	

[MEMO]

No part of this document may be copied or reproduced in any form or by any means without the prior written consent of NEC Corporation. NEC Corporation assumes no responsibility for any errors which may appear in this document.

NEC Corporation does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from use of a device described herein or any other liability arising from use of such device. No license, either express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC Corporation or others.

The devices listed in this document are not suitable for use in aerospace equipment, submarine cables, nuclear reactor control systems and life support systems. If customers intend to use NEC devices for above applications or they intend to use "Standard" quality grade NEC devices for applications not intended by NEC, please contact our sales people in advance.

Application examples recommended by NEC Corporation

Standard: Computer, Office equipment, Communication equipment, Test and Measurement equipment, Machine tools, Industrial robots, Audio and Visual equipment, Other consumer products, etc.

Special: Automotive and Transportation equipment, Traffic control systems, Antidisaster systems, Anticrime systems, etc.

M4 92.6